

# 900V N-Channel MOSFET

#### **General Features**

- Proprietary New Planar Technology
- R<sub>DS(ON),typ</sub>=1.12 Ω@V<sub>GS</sub>=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

# **Applications**

- Adaptor Charger
- SMPS Power Supply
- LCD Panel Power

### **Ordering Information**

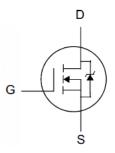
Part Number	Package	Brand
PTW09N90	TO-3P	ž

## **Absolute Maximum Ratings**

#### Lead Free Package and Finish

BV <sub>DSS</sub>	R <sub>DS(ON),typ.</sub>	I <sub>D</sub>
900V	1.12Ω	9A





 $T_C {=} 25\,^\circ\!\mathrm{C}$  unless otherwise specified

Symbol	Parameter	PTW09N90	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	900	- V	
V <sub>GSS</sub>	Gate-to-Source Voltage	±30	− v	
I <sub>D</sub>	Continuous Drain Current	9.0		
<b>I<sub>D @ Tc =100</sub> ℃</b>	Continuous Drain Current @ Tc=100℃	Figure 3	A	
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2]</sup>	Figure 6	1	
E <sub>AS</sub>	Single Pulse Avalanche Energy	580	mJ	
dv/dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	1000	V/ns	
D	Power Dissipation	240	W	
P <sub>D</sub>	Derating Factor above 25°C	2.0	W/°C	
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	°C	
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

# **Thermal Characteristics**

Symbol	Parameter	PTW09N90	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	0.50	20.000
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	62	°C <i>I</i> W



# **Electrical Characteristics**

#### OFF Characteristics T<sub>J</sub> =25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	900			V	$V_{GS}$ =0V, I <sub>D</sub> =250uA
	Drain to Course Lookage Current			1		V <sub>DS</sub> =900V, V <sub>GS</sub> =0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250 uA	UA	V <sub>DS</sub> =720V, V <sub>GS</sub> =0V, TJ =125℃
1	Cate to Source Leakage Current			+100	nA	$V_{GS}$ =+30V, $V_{DS}$ =0V
I <sub>GSS</sub>	Gate-to-Source Leakage Current			-100	ПA	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V

ON Characteristics
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 $T_{\rm J}$  =25  $^\circ\!{\rm C}$  unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance <sup>[4]</sup>		1.2	1.4	Ω	$V_{GS}$ =10V, I <sub>D</sub> =4.5A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$ , I <sub>D</sub> =250uA
gfs	Forward Transconductance <sup>[4]</sup>		10		S	VDS=30V,ID=9A
Rg	Gate Resistance		1.4		Ω	Vds=0V,F=1MHz

#### **Dynamic Characteristics**

Symbol

 $\boldsymbol{C}_{\text{iss}}$ 

 $C_{rss}$ 

Essentially independent of operating temperature Parameter Min. Тур. Max. Unit **Test Conditions** Input Capacitance 2500 \_\_ \_\_\_  $V_{GS}$ =0V,  $V_{DS}$ =25V, f=1.0MH<sub>Z</sub> **Reverse Transfer Capacitance** 12 рF ••

C <sub>oss</sub>	Output Capacitance	 140		
Qg	Total Gate Charge	 48		
Q <sub>gs</sub>	Gate-to-Source Charge	 12	 nC	V <sub>DD</sub> =450V, I <sub>D</sub> =9A, V <sub>GS</sub> =0 to 10V
Q <sub>gd</sub>	Gate-to-Drain (Miller) Charge	 16		

#### **Resistive Switching Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		35			
trise	Rise Time		40		- ns	$V_{DD}$ =450V, $I_{D}$ =9A, $V_{GS}$ = 10V RG=4.7 Ω
td(OFF)	Turn-Off Delay Time		130			
tfall	Fall Time		45			



### **Source-Drain Body Diode Characteristics**

 $T_J {=} 25\,^\circ\!\! \mathrm{C}$  unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I <sub>SD</sub>	Continuous Source Current <sup>[4]</sup>			9	A	Integral PN-diode in MOSFET
I <sub>SM</sub>	Pulsed Source Current <sup>[4]</sup>			36		
$V_{SD}$	Diode Forward Voltage			1.5	V	I <sub>S</sub> =9A, V <sub>GS</sub> =0V
trr	Reverse recovery time		500		ns	V <sub>GS</sub> =0V ,I <sub>F</sub> =9A,
Qrr	Reverse recovery charge		3.0		uC	di⊧/dt=100A/µs

Note:

[1] T<sub>J</sub>=+25℃ to +150℃

- [2] Repetitive rating; pulse width limited by maximum junction temperature.
  [3] ISD= 9A di/dt < 100 A/µs, VDD < BVDSs, TJ=+150 °C.</li>
- [4] Pulse width≤380µs; duty cycle≤2%.

# **Typical Characteristics**

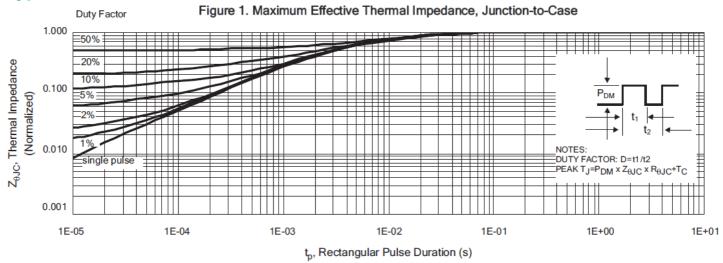


Figure 2. Maximum Power Dissipation vs Case Temperature

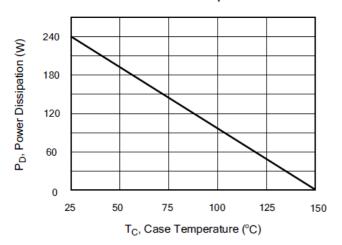


Figure 4. Typical Output Characteristics

PULSE DURATION = 250 µS DUTY FACTOR = 0.5% MAX

 $T_C = 25^{\circ}C$ 

16

14

12

10

8

6

4

2 0

0

5

10

15

V<sub>DS</sub>, Drain-to-Source Voltage (V)

20

ID, Drain Current (A)

Figure3. Maximum Continuous Drain Current vs Case Temperature

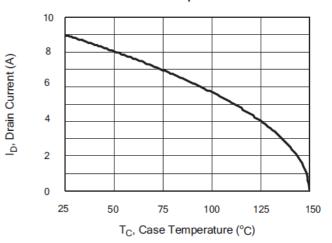
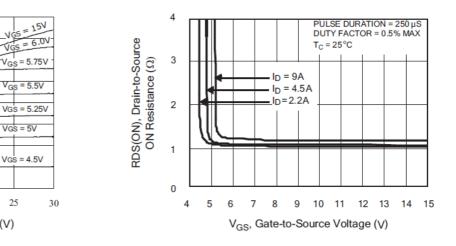


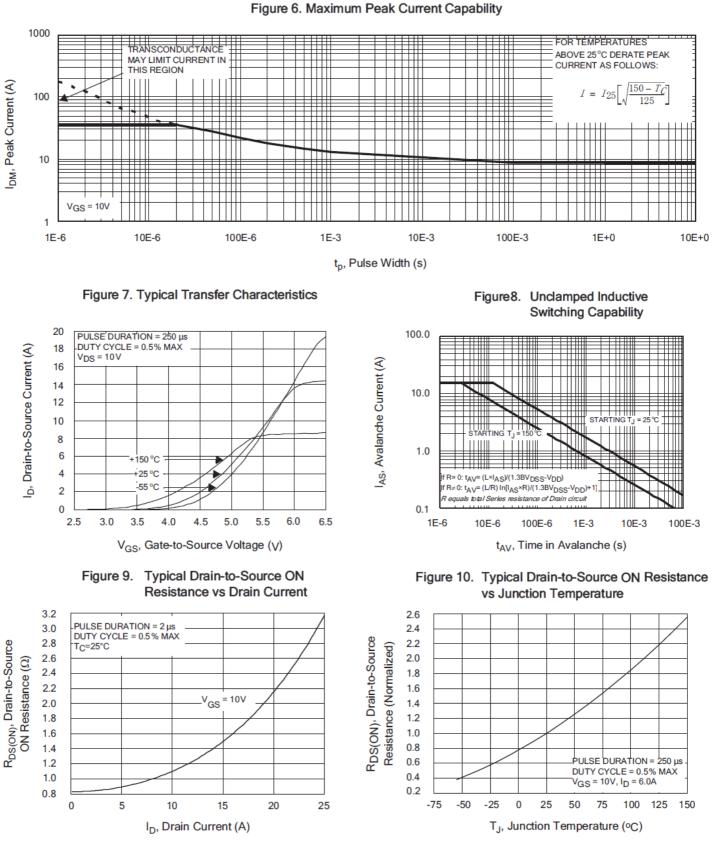
Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



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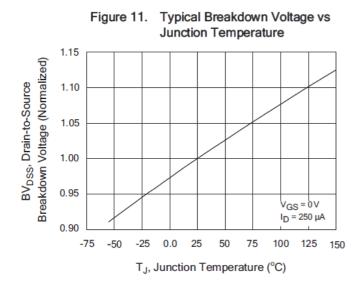
VGS

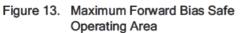
# Typical Characteristics(Cont.)





# **Typical Characteristics**(Cont.)





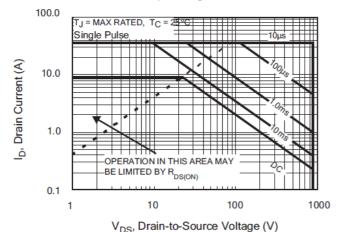
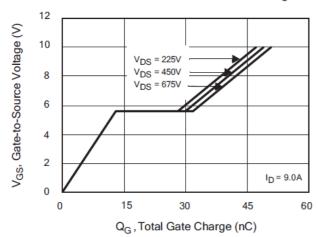


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage



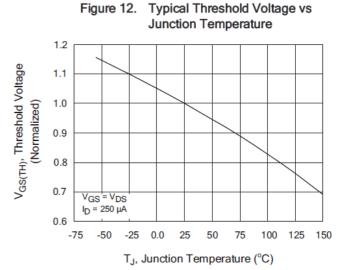


Figure 14. Typical Capacitance vs



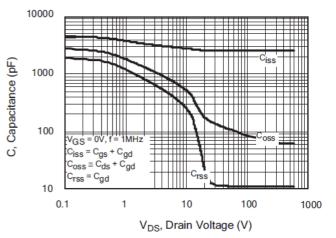
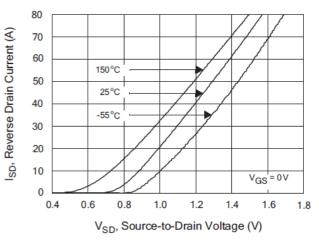
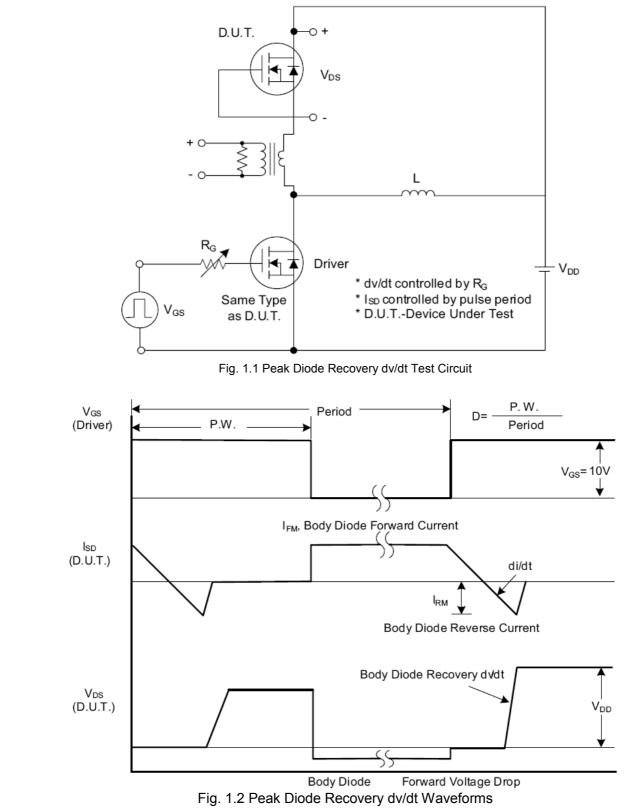


Figure 16. Typical Body Diode Transfer Characteristics



# **Test Circuits and Waveforms**





# **PTW09N90**

# Test Circuits and Waveforms (Cont.)

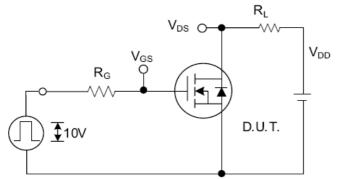


Fig. 2.1 Switching Test Circuit

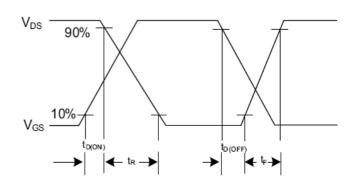


Fig. 2.2 Switching Waveforms

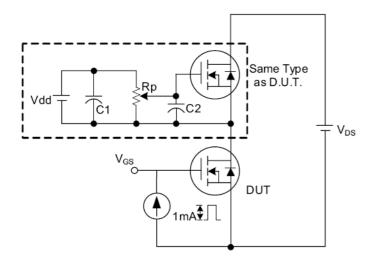


Fig. 3.1 Gate Charge Test Circuit

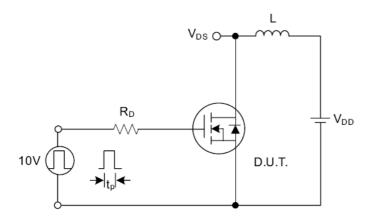


Fig. 4.1 Unclamped Inductive Switching Test Circuit

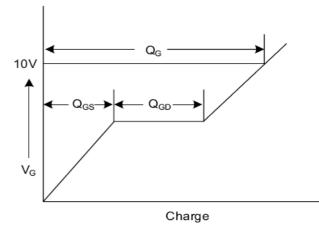
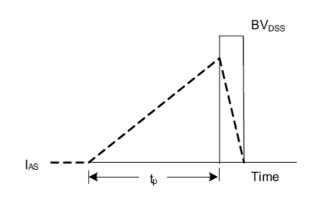
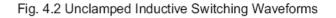


Fig. 3.2 Gate Charge Waveform





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